

LIST OF PATENTS AND PUBLICATIONS FOR  
APPLICANT'S INFORMATION DISCLOSURE  
STATEMENT

APPLICANT

FILING DATE

GROUP

(Use several sheets if necessary)

JP474 U.S. PTO  
09/625603  
07/26/00

## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MRL	AA	5	7	6	6	5	4	7	6/16/98	Kay et al.	422/5		2/4/97
MRL	AB	5	5	6	7	4	0	2	10/22/96	Vicard et al.	423/245.2		5/6/92
MRL	AC	5	3	0	2	3	5	9	4/12/94	Nowatzki	422/306		11/18/92
MRL	AD	5	1	6	0	7	0	7	11/3/92	Murray et al.	422/170		12/7/90
MRL	AE	4	2	5	6	7	1	0	3/17/81	Azuma et al.	423/210		9/26/79
MRL	AF	4	0	6	7	6	9	2	1/10/78	Farris	21/74R		6/10/76
MRL	AG	3	9	6	9	4	7	9	7/13/76	Lonnes et al.	423/210		9/11/73
MRL	AH	5	5	4	9	2	4	7	8/27/96	Rossman et al.	239/57		12/27/94
MRL	AI	5	4	1	7	9	2	0	5/23/95	Yung	422/5		9/13/93
MRL	AJ	5	0	7	1	6	2	2	12/10/91	Dunson, Jr.	422/5		9/15/89
MRL	AK	5	2	4	8	4	4	8	9/28/93	Waldron et al.	252/305		3/15/91

## FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	TRANSLATION	
													YES	NO
	AL													
	AM													
	AN													
	AO													
	AP													

## OTHER

ART (Including Author, Title, Date, Pertinent Pages, Etc.)

MRL	AR		Hinsilblon Laboratories EVANE/SCENT brochure, April 23, 1997
	AS		
	AT		

EXAMINER

DATE CONSIDERED

Morgan R. Chalij

06/07/2002

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformation and not considered. Include copy of this form with next communication to applicant.

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MRC	AA	5	3	1	4	6	1	9		5/24/94	Runyon	210/606		3/22/93
MRC	AB	5	3	6	4	0	3	0		11/15/94	Murdock et al.	239/310		7/29/93
	AC													
	AD													
	AE													
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EXAMINER

*Margaret Charlup*

DATE CONSIDERED

*06/07/2002*

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